

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/005,193	CHEN ET AL.
	Examiner	Art Unit
	Fred I. Ehichioya	2162

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
707	5, 102	4/6/2006	FE
707	103R	4/6/2006	FE
707	104.1	4/6/2006	FE

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search	4/6/2006	FE
Google.com	4/6/2006	FE
ACM Digital Library	4/6/2006	FE
EIC	4/14/2006	FE